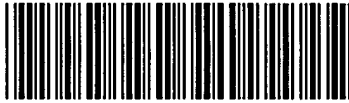


**Search Notes**

Application/Control No.

10/707,681

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under  
Reexamination

TU, CHIN-FA

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
720	610	7/31/2006	MK
720	639	7/31/2006	MK
720	637	7/31/2006	MK
720	636	7/31/2006	MK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	7/31/2006	MK